## - $5-\Omega$ Switch Connection Between Two Ports <br> - TTL-Compatible Input Levels <br> - Designed to Be Used in Level-Shifting Applications <br> description/ordering information

The SN74CBTD3861 provides ten bits of high-speed TTL-compatible bus switching. The low on-state resistance of the switch allows connections to be made with minimal propagation delay. A diode to $\mathrm{V}_{\mathrm{CC}}$ is integrated on the die to allow for level shifting from $5-\mathrm{V}$ signals at the device inputs to $3.3-\mathrm{V}$ signals at the device outputs.

The device is organized as one 10 -bit switch with a single output-enable ( $\overline{\mathrm{OE}}$ ) input. When $\overline{\mathrm{OE}}$ is low, the switch is on, and port A is connected to port B . When $\overline{\mathrm{OE}}$ is high, the switch is open, and the high-impedance state exists between the two ports.

DB, DBQ, DGV, DW, OR PW PACKAGE (TOP VIEW)

| NC 1 | ${ }_{1} \cup_{24}$ | $\mathrm{V}_{\mathrm{CC}}$ |
| :---: | :---: | :---: |
| $1[$ | $2 \quad 23$ | OE |
| A2 3 | 322 | B1 |
| - | 421 | B2 |
| A4 | 520 | B3 |
| $5{ }^{6}$ | $6 \quad 19$ | B4 |
| A6 7 | $7 \quad 18$ | B5 |
| $7{ }^{\text {a }}$ | 8 | B6 |
| 8 | 916 | B7 |
| A9 | $10 \quad 15$ | B8 |
| A10 | $11 \quad 14$ | B9 |
| GND | $12 \quad 13$ | B10 |

NC - No internal connection

ORDERING INFORMATION

| $\mathrm{T}_{\mathrm{A}}$ | PACKAGE $\dagger$ |  | ORDERABLE PART NUMBER | TOP-SIDE MARKING |
| :---: | :---: | :---: | :---: | :---: |
| $-40^{\circ} \mathrm{C}$ to $85^{\circ} \mathrm{C}$ | SOIC - DW | Tube | SN74CBTD3861DW | CBTD3861 |
|  |  | Tape and reel | SN74CBTD3861DWR |  |
|  | SSOP - DB | Tape and reel | SN74CBTD3861DBR | CC861 |
|  | SSOP (QSOP) - DBQ | Tape and reel | SN74CBTD3861DBQR | CBTD3861 |
|  | TSSOP - PW | Tape and reel | SN74CBTD3861PWR | CC861 |
|  | TVSOP - DGV | Tape and reel | SN74CBTD3861DGVR | CC861 |

† Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

FUNCTION TABLE

| INPUT <br> OE | FUNCTION |
| :---: | :---: |
| L | A port $=$ B port |
| H | Disconnect |

## logic diagram (positive logic)


absolute maximum ratings over operating free-air temperature range (unless otherwise noted) $\dagger$

Input voltage range, $\mathrm{V}_{\mathrm{I}}$ (see Note 1) ............................................................ -0.5 V to 7 V
Continuous channel current ............................................................................. 128 mA

Package thermal impedance, $\theta_{\mathrm{JA}}$ (see Note 2): DB package ..................................... 63² $\mathrm{C} / \mathrm{W}$
DBQ package .......................................... $61^{\circ} \mathrm{C} / \mathrm{W}$
DGV package ....................................... $86^{\circ} \mathrm{C} / \mathrm{W}$
DW package ....................................... $46^{\circ} \mathrm{C} / \mathrm{W}$
PW package ....................................... $88^{\circ} \mathrm{C} / \mathrm{W}$

$\dagger$ Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
2. The package thermal impedance is calculated in accordance with JESD 51-7.
recommended operating conditions (see Note 3)

|  |  | MIN | MAX |
| :--- | :--- | ---: | :---: |
| $\mathrm{V}_{\mathrm{CC}}$ | UNIT |  |  |
| $\mathrm{V}_{\mathrm{IH}}$ | High-level control input voltage | 4.5 | 5.5 |
| $\mathrm{~V}_{\mathrm{IL}}$ | Low-level control input voltage | 2 | V |
| $\mathrm{~T}_{\mathrm{A}}$ | Operating free-air temperature | -40 | 8 |

In applications with fast edge rates, multiple outputs switching, and operating at high frequencies, the output may have little or no level-shifting effect.
NOTE 3: All unused control inputs of the device must be held at $\mathrm{V}_{\mathrm{CC}}$ or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.
electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER |  | TEST CONDITIONS |  |  | MIN | TYP $\dagger$ | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\text {IK }}$ |  | $\mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V}$, | $1 \mathrm{l}=-18 \mathrm{~mA}$ |  |  |  | -1.2 | V |
| $\mathrm{V}_{\mathrm{OH}}$ |  | See Figure 2 |  |  |  |  |  |  |
| I |  | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$, | $\mathrm{V}_{\mathrm{I}}=5.5 \mathrm{~V}$ or GND |  |  |  | $\pm 1$ | $\mu \mathrm{A}$ |
| ICC |  | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$, | $\mathrm{I} \mathrm{O}=0$, | $\mathrm{V}_{1}=\mathrm{V}_{\text {CC }}$ or GND |  |  | 1.5 | mA |
| $\Delta_{\text {l }} \mathrm{CC}^{\ddagger}$ | Control inputs | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$, | One input at 3.4 V, | Other inputs at $\mathrm{V}_{\mathrm{CC}}$ or GND |  |  | 2.5 | mA |
| $\mathrm{C}_{\mathrm{i}}$ | Control inputs | $\mathrm{V}_{\mathrm{I}}=3 \mathrm{~V}$ or 0 |  |  |  | 2.5 |  | pF |
| $\mathrm{Cio}_{\mathrm{io}}$ (OFF) |  | $\mathrm{V}_{\mathrm{O}}=3 \mathrm{~V}$ or 0 , | $\overline{\mathrm{OE}}=\mathrm{V}_{\mathrm{CC}}$ |  |  | 4 |  | pF |
| $\mathrm{ron}^{\text {§ }}$ |  | $\mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V}$ | $\mathrm{V}_{\mathrm{I}}=0$ | I $=64 \mathrm{~mA}$ |  | 5 | 7 | $\Omega$ |
|  |  | I $=30 \mathrm{~mA}$ |  |  | 5 | 7 |  |
|  |  | V I $=2.4 \mathrm{~V}$, | $\mathrm{I}=15 \mathrm{~mA}$ |  | 20 | 50 |  |

$\dagger$ All typical values are at $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$.
$\ddagger$ This is the increase in supply current for each input that is at the specified TTL voltage level rather than $V_{C C}$ or GND.
§ Measured by the voltage drop between the A and B terminals at the indicated current through the switch. On-state resistance is determined by the lowest voltage of the two ( A or B ) terminals.
switching characteristics over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

| PARAMETER | FROM (INPUT) | TO (OUTPUT) | MIN | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: |
| $t_{\text {pd }}{ }^{\text {I }}$ | A or B | B or A |  | 0.35 | ns |
| ten | $\overline{\mathrm{OE}}$ | A or B | 2.6 | 10 | ns |
| $\mathrm{t}_{\text {dis }}$ | $\overline{\mathrm{OE}}$ | A or B | 1 | 6 | ns |

[^0]
## PARAMETER MEASUREMENT INFORMATION



LOAD CIRCUIT


VOLTAGE WAVEFORMS
PROPAGATION DELAY TIMES


VOLTAGE WAVEFORMS ENABLE AND DISABLE TIMES

NOTES: A. $C_{L}$ includes probe and jig capacitance.
B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
C. All input pulses are supplied by generators having the following characteristics: $\mathrm{PRR} \leq 10 \mathrm{MHz}, \mathrm{Z}_{\mathrm{O}}=50 \Omega, \mathrm{t}_{\mathrm{r}} \leq 2.5 \mathrm{~ns}, \mathrm{t}_{\mathrm{f}} \leq 2.5 \mathrm{~ns}$.
D. The outputs are measured one at a time with one transition per measurement.
E. $t_{P L Z}$ and $t_{P H Z}$ are the same as $t_{d i s}$.
F. $t_{P Z L}$ and $t_{P Z H}$ are the same as ten.
G. tPLH and tPHL are the same as tpd.

Figure 1. Load Circuit and Voltage Waveforms

## TYPICAL CHARACTERISTICS



OUTPUT VOLTAGE HIGH
vs
SUPPLY VOLTAGE


Figure 2. $\mathrm{V}_{\mathrm{OH}}$ Values

## PACKAGING INFORMATION

| Orderable Device | Status <br> (1) | Package Type | Package Drawing | Pins | Package Qty | Eco Plan <br> (2) | Lead/Ball Finish <br> (6) | MSL Peak Temp <br> (3) | Op Temp ( ${ }^{\circ} \mathrm{C}$ ) | Device Marking <br> (4/5) | Samples |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 74CBTD3861DBQRE4 | ACTIVE | SSOP | DBQ | 24 | 2500 | Green (RoHS \& no $\mathrm{Sb} / \mathrm{Br}$ ) | CU NIPDAU | Level-2-260C-1 YEAR | -40 to 85 | CBTD3861 | Samples |
| 74CBTD3861DBQRG4 | ACTIVE | SSOP | DBQ | 24 | 2500 | Green (RoHS \& no $\mathrm{Sb} / \mathrm{Br}$ ) | CU NIPDAU | Level-2-260C-1 YEAR | -40 to 85 | CBTD3861 | Samples |
| SN74CBTD3861DBQR | ACTIVE | SSOP | DBQ | 24 | 2500 | Green (RoHS \& no $\mathrm{Sb} / \mathrm{Br}$ ) | CU NIPDAU | Level-2-260C-1 YEAR | -40 to 85 | CBTD3861 | Samples |
| SN74CBTD3861DBR | ACTIVE | SSOP | DB | 24 | 2000 | Green (RoHS \& no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -40 to 85 | CC861 | Samples |
| SN74CBTD3861DBRG4 | ACTIVE | SSOP | DB | 24 | 2000 | Green (RoHS \& no $\mathrm{Sb} / \mathrm{Br}$ ) | CU NIPDAU | Level-1-260C-UNLIM | -40 to 85 | CC861 | Samples |
| SN74CBTD3861DGVR | ACTIVE | TVSOP | DGV | 24 | 2000 | Green (RoHS \& no $\mathrm{Sb} / \mathrm{Br}$ ) | CU NIPDAU | Level-1-260C-UNLIM | -40 to 85 | CC861 | Samples |
| SN74CBTD3861DW | ACTIVE | SOIC | DW | 24 | 25 | Green (RoHS \& no $\mathrm{Sb} / \mathrm{Br}$ ) | CU NIPDAU | Level-1-260C-UNLIM | -40 to 85 | CBTD3861 | Samples |
| SN74CBTD3861DWG4 | ACTIVE | SOIC | DW | 24 | 25 | Green (RoHS \& no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -40 to 85 | CBTD3861 | Samples |
| SN74CBTD3861DWR | ACTIVE | SOIC | DW | 24 | 2000 | Green (RoHS \& no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -40 to 85 | CBTD3861 | Samples |
| SN74CBTD3861PW | ACTIVE | TSSOP | PW | 24 | 60 | Green (RoHS \& no $\mathrm{Sb} / \mathrm{Br}$ ) | CU NIPDAU | Level-1-260C-UNLIM | -40 to 85 | CC861 | Samples |
| SN74CBTD3861PWE4 | ACTIVE | TSSOP | PW | 24 | 60 | Green (RoHS \& no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -40 to 85 | CC861 | Samples |
| SN74CBTD3861PWG4 | ACTIVE | TSSOP | PW | 24 | 60 | Green (RoHS \& no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -40 to 85 | CC861 | Samples |
| SN74CBTD3861PWR | ACTIVE | TSSOP | PW | 24 | 2000 | Green (RoHS \& no $\mathrm{Sb} / \mathrm{Br}$ ) | CU NIPDAU | Level-1-260C-UNLIM | -40 to 85 | CC861 | Samples |
| SN74CBTD3861PWRE4 | ACTIVE | TSSOP | PW | 24 | 2000 | Green (RoHS \& no $\mathrm{Sb} / \mathrm{Br}$ ) | CU NIPDAU | Level-1-260C-UNLIM | -40 to 85 | CC861 | Samples |

${ }^{(1)}$ The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs.
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
NRND: Not recommended for new designs. Device is in production to support existing customers, but Tl does not recommend using this part in a new design.
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device.
${ }^{(2)}$ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS \& no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed $0.1 \%$ by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.
Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb -Free (RoHS compatible) as defined above.
Green (RoHS \& no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed $0.1 \%$ by weight in homogeneous material)
${ }^{(3)}$ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
${ }^{(4)}$ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
${ }^{(5)}$ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
${ }^{(6)}$ Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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## TAPE AND REEL INFORMATION

REEL DIMENSIONS


W1

TAPE AND REEL INFORMATION
*All dimensions are nominal

| Device | Package <br> Type | Package <br> Drawing | Pins | SPQ | Reel <br> Diameter <br> $(\mathbf{m m})$ | Reel <br> Width <br> $\mathbf{W 1}(\mathbf{m m})$ | A0 <br> $(\mathbf{m m})$ | B0 <br> $(\mathbf{m m})$ | K0 <br> $(\mathbf{m m})$ | P1 <br> $(\mathbf{m m})$ | $\mathbf{W}$ <br> $(\mathbf{m m})$ | Pin1 <br> Quadrant |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| SN74CBTD3861DBQR | SSOP | DBQ | 24 | 2500 | 330.0 | 16.4 | 6.5 | 9.0 | 2.1 | 8.0 | 16.0 | Q1 |
| SN74CBTD3861DBR | SSOP | DB | 24 | 2000 | 330.0 | 16.4 | 8.2 | 8.8 | 2.5 | 12.0 | 16.0 | Q1 |
| SN74CBTD3861DGVR | TVSOP | DGV | 24 | 2000 | 330.0 | 12.4 | 6.9 | 5.6 | 1.6 | 8.0 | 12.0 | Q1 |
| SN74CBTD3861DWR | SOIC | DW | 24 | 2000 | 330.0 | 24.4 | 10.75 | 15.7 | 2.7 | 12.0 | 24.0 | Q1 |
| SN74CBTD3861PWR | TSSOP | PW | 24 | 2000 | 330.0 | 16.4 | 6.95 | 8.3 | 1.6 | 8.0 | 16.0 | Q1 |


*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| SN74CBTD3861DBQR | SSOP | DBQ | 24 | 2500 | 367.0 | 367.0 | 38.0 |
| SN74CBTD3861DBR | SSOP | DB | 24 | 2000 | 367.0 | 367.0 | 38.0 |
| SN74CBTD3861DGVR | TVSOP | DGV | 24 | 2000 | 367.0 | 367.0 | 35.0 |
| SN74CBTD3861DWR | SOIC | DW | 24 | 2000 | 367.0 | 367.0 | 45.0 |
| SN74CBTD3861PWR | TSSOP | PW | 24 | 2000 | 367.0 | 367.0 | 38.0 |



| PIM ** | $\mathbf{1 4}$ | $\mathbf{1 6}$ | $\mathbf{2 0}$ | $\mathbf{2 4}$ | $\mathbf{3 8}$ | $\mathbf{4 8}$ | $\mathbf{5 6}$ |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| A MAX | 3,70 | 3,70 | 5,10 | 5,10 | 7,90 | 9,80 | 11,40 |
| A MIN | 3,50 | 3,50 | 4,90 | 4,90 | 7,70 | 9,60 | 11,20 |

NOTES: A. All linear dimensions are in millimeters.
B. This drawing is subject to change without notice.
C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15 per side.
D. Falls within JEDEC: $24 / 48$ Pins - MO-153

14/16/20/56 Pins - MO-194

DW (R-PDSO-G24) PLASTIC SMALL OUTLINE


NOTES: A. All linear dimensions are in inches (millimeters). Dimensioning and tolerancing per ASME Y14.5M-1994.
B. This drawing is subject to change without notice.
C. Body dimensions do not include mold flash or protrusion not to exceed $0.006(0,15)$.
D. Falls within JEDEC MS-013 variation AD.

DBQ (R-PDSO-G24) PLASTIC SMALL-OUTLINE PACKAGE


NOTES: A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
C. Body dimensions do not include mold flash or protrusion not to exceed $0.006(0,15)$ per side.
D. Falls within JEDEC MO-137 variation AE.

PW (R-PDSO-G24)


NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
B. This drawing is subject to change without notice.

C Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shal not exceed 0,15 each side
(D) Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
E. Falls within JEDEC MO-153
5 PW (R—PDSO-G24)

NOTES: A. All linear dimensions are in millimeters.
B. This drawing is subject to change without notice.
C. Publication IPC-7351 is recommended for alternate design.
D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.


| DIM PINS ** | $\mathbf{1 4}$ | $\mathbf{1 6}$ | $\mathbf{2 0}$ | $\mathbf{2 4}$ | $\mathbf{2 8}$ | $\mathbf{3 0}$ | $\mathbf{3 8}$ |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| A MAX | 6,50 | 6,50 | 7,50 | 8,50 | 10,50 | 10,50 | 12,90 |
| A MIN | 5,90 | 5,90 | 6,90 | 7,90 | 9,90 | 9,90 | 12,30 |

NOTES: A. All linear dimensions are in millimeters.
B. This drawing is subject to change without notice.
C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.
D. Falls within JEDEC MO-150

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## Applications

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TI E2E Community
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www.ti.com/industrial
www.ti.com/medical
www.ti.com/security
www.ti.com/space-avionics-defense
www.ti.com/video
e2e.ti.com
www.ti.com/wirelessconnectivity


[^0]:    IThe propagation delay is the calculated RC time constant of the typical on-state resistance of the switch and the specified load capacitance, when driven by an ideal voltage source (zero output impedance).

